



DRD1
Gaseous Detector Technologies



Field-Assisted Transparent Gaseous Electroluminescence Multipliers (FAT GEM) - Updates



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Outline



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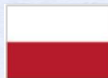
1. Dark Matter detection challenges
2. Brief FAT-GEM history
3. New production @AstroCeNT
4. Experimental campaign
5. Results
6. Ongoing work
7. Conclusions



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Dark Matter detection challenges

Dual-phase detectors are a preferred choice in **Dark Matter searches** (XENON, LZ, DarkSide). Detection rely on **electroluminescence** mechanism in the gas phase.

Improving sensitivity:

- Improving the background rejections
- Lower detection threshold
- Larger exposure (mass x time)



Improve light collection efficiency:

- Ar based detectors → VUV emission → need of WLS
- Meshes and wires widely use as amplification stage:
 - Loss of tension with time
 - Difficult to scale up to large areas
 - Lack of modularity
 - No option of direct coupling to solid WLS
 - Difficulties at extracting e⁻ from the liquid-gas interface



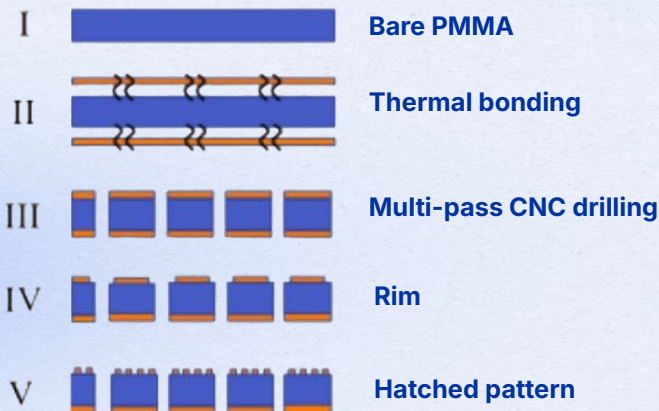
Field Assisted Transparent Gaseous Electroluminescence Multiplier (FAT GEMs)

- Integration with **WLS coatings**
- Modular, **tileable**, and **radiopure**
- Robust mechanical design

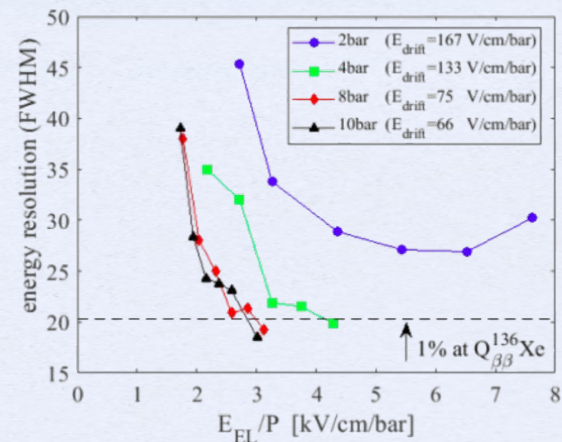
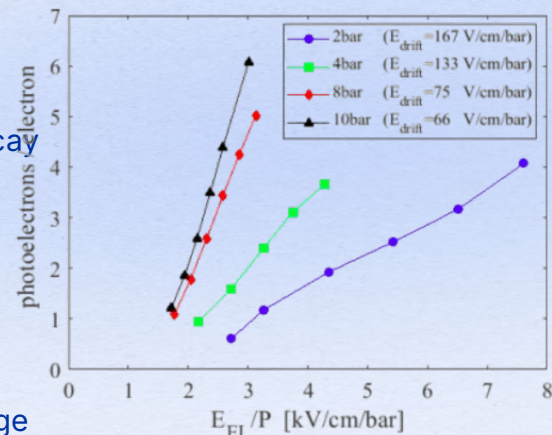
Brief FAT-GEM history (I)

FAT GEMs introduced in **2020**. Originally developed for neutrino-less double beta decay in HP-Xenon

- Intrinsically **radiopure** (based on PMMA and Cu)
- Flexibility to tune optical properties (solid WLS, reflectivity and transmission)
- **Proof-of-principle:** (D. González-Díaz et al., J. Phys. Conf. Ser., 1498 (2020) 012019.)
- Structure inherently **stable** up to 3kV/cm/bar at 10bar (about x2.5 higher voltage than NEXT-NEW)



EL field scan

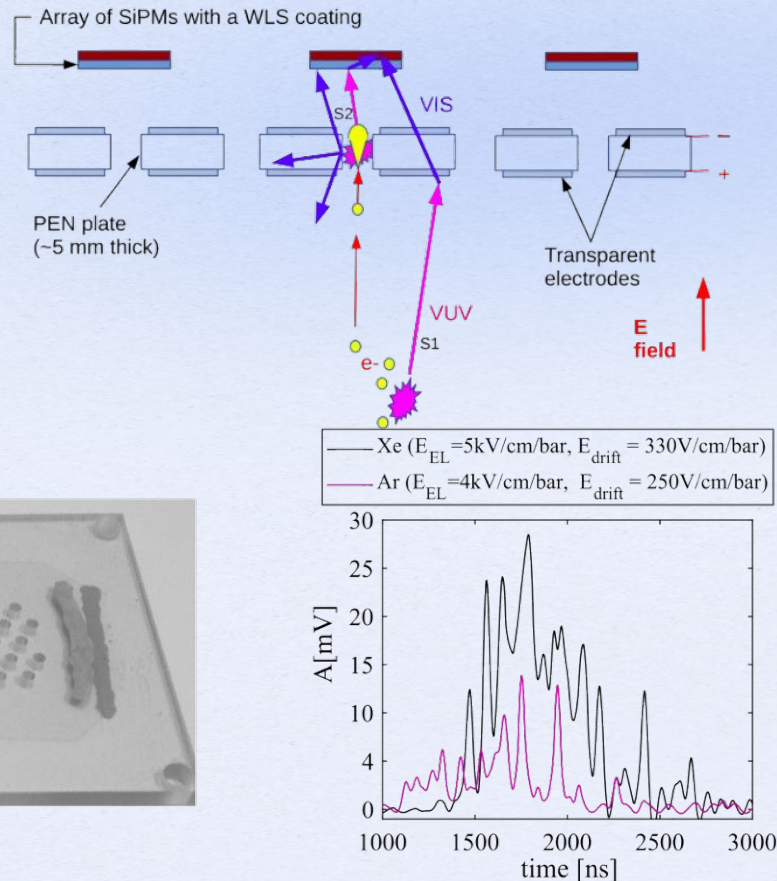
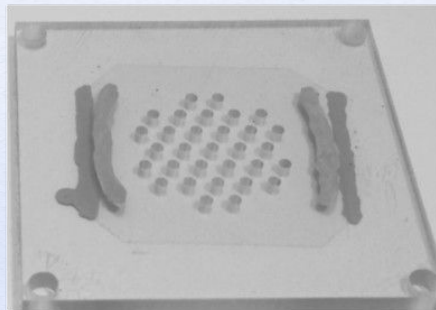
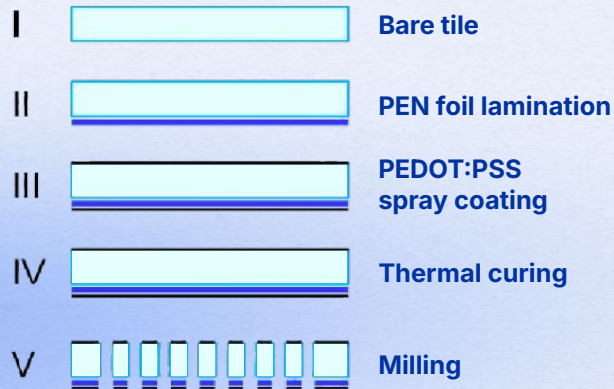


Brief FAT-GEM history (II)

WLS implementation

(M. Kuźniak et al., Eur. Phys. J. C, 81 (2021) 609.)

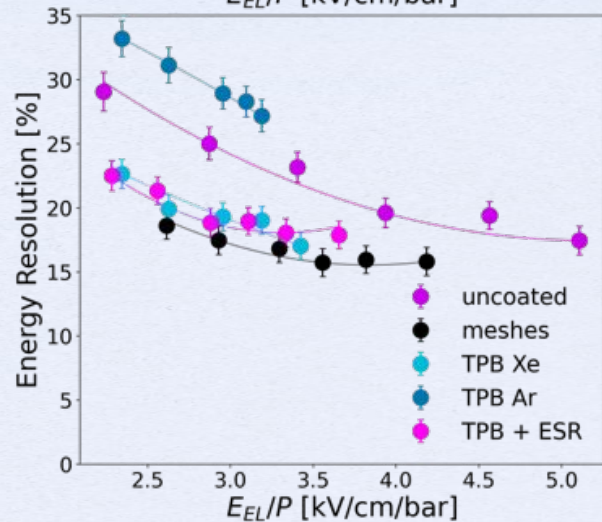
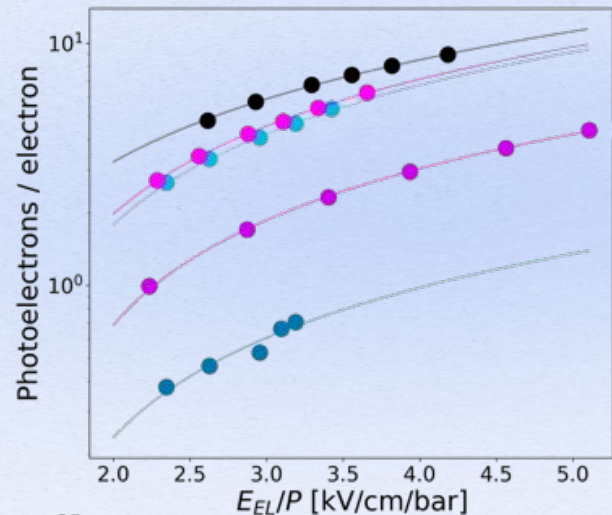
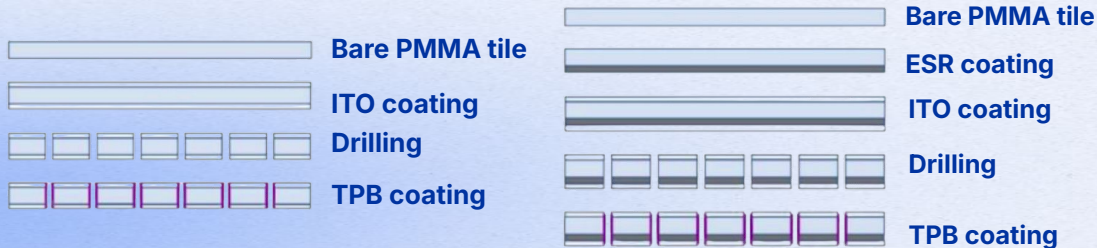
- Use transparent bulk material (PEN) as solid WLS.
- Demonstrated **first operation in Ar with conventional (Ar-blind) photosensors**.



Brief FAT-GEM history (III)

Introduce new procedures: (S. Leardini et al., Sci. Technol. 2 (2024) 1373235.)

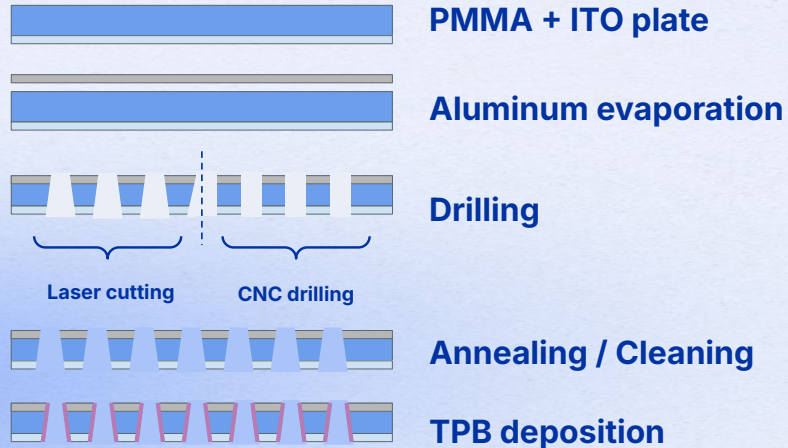
- Incorporates reflective (ESR) and transparent ITO films to the structure to enhance light collection.
- New method to evaporate TPB into the holes' walls.
- Demonstrated **performance comparable** to that obtained under **parallel meshes**.



New production @AstroCeNT

Limitations encountered:

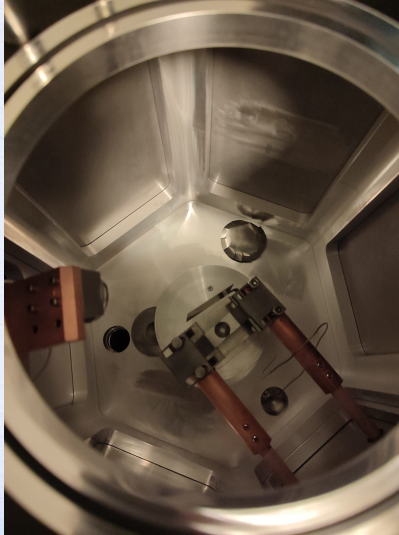
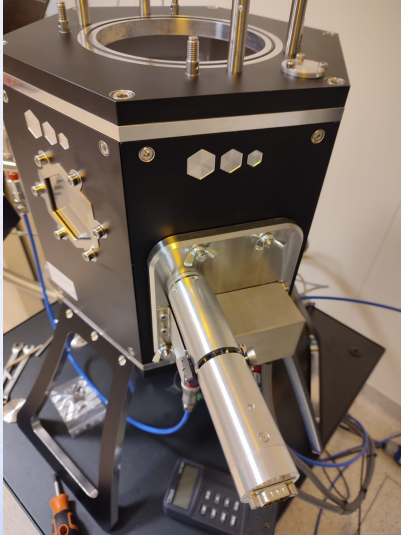
- ESR producing **charging up** of the structure.
- ITO and ESR as an **adhesive film**
- ITO transparency: 80%



Upgrades from last production:

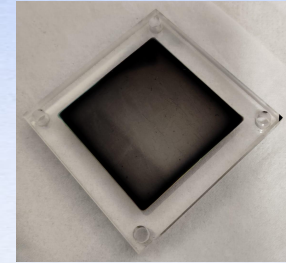
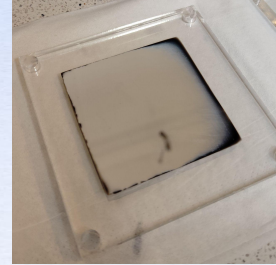
- Replacing ESR for **Aluminum electrode**, removes charging up keeping reflectivity at similar values.
- Adhesive ITO replaced for **magnetron sputtered ITO**.
 - Higher transparency (from 80% to 90%)
- **Laser drilling** instead of CNC drilling.
 - Explore the impact of different hole geometries

Aluminum evaporation



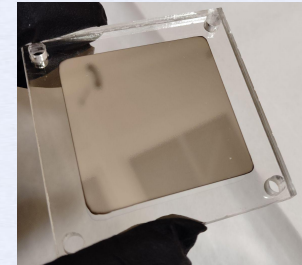
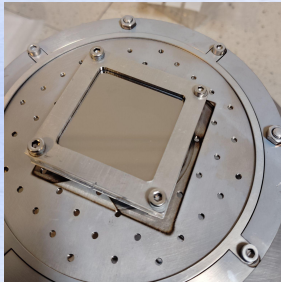
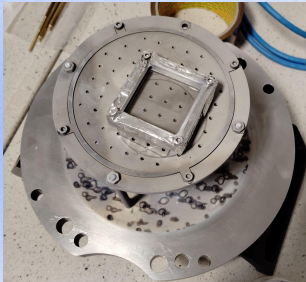
Problems faced:

- Dark spots
- Completely black electrode – non reflective



Optimization of evaporator parameters:

- Vacuum
- Temperature
- **Rate** and thickness
- **Frames**



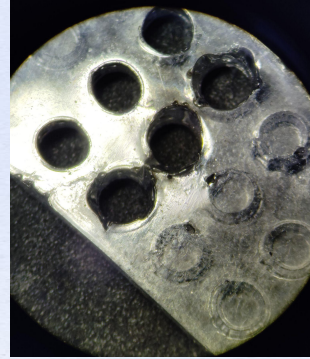
Laser drilling



Main **advantages:**

- Fully autonomous production
- Easy and fast production
- Try different geometries

Problems faced:



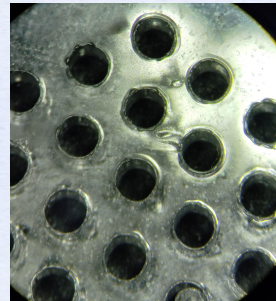
Grid reflections



White spots

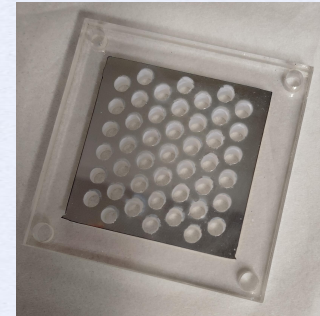
Fixed:

Adding a spacer



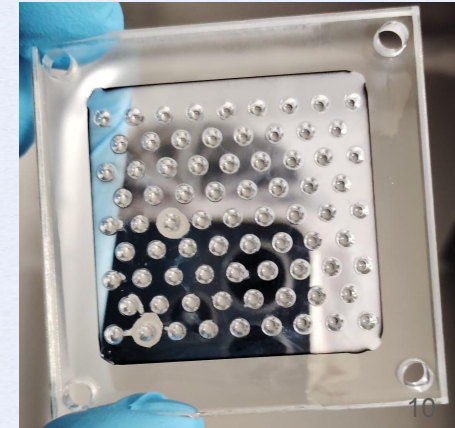
Fixed:

Laser power and time between holes



Annealing / Cleaning + TPB deposition

- **Laser drilling** exposes the bulk material to localized high temperatures that produces stress in it. **Annealing** is needed to reduce the stress and recover material properties.
- **CNC drilling** might leave residual oils or other materials in the holes. A cleaning process is needed to reduce impurities.
 - Ultrasonic bath is very aggressive and might end up removing the Aluminum layer.
 - Specific soap and brushes were used.
- **TPB** was deposited in the holes of the structures. However, there might be some uniformities in them.



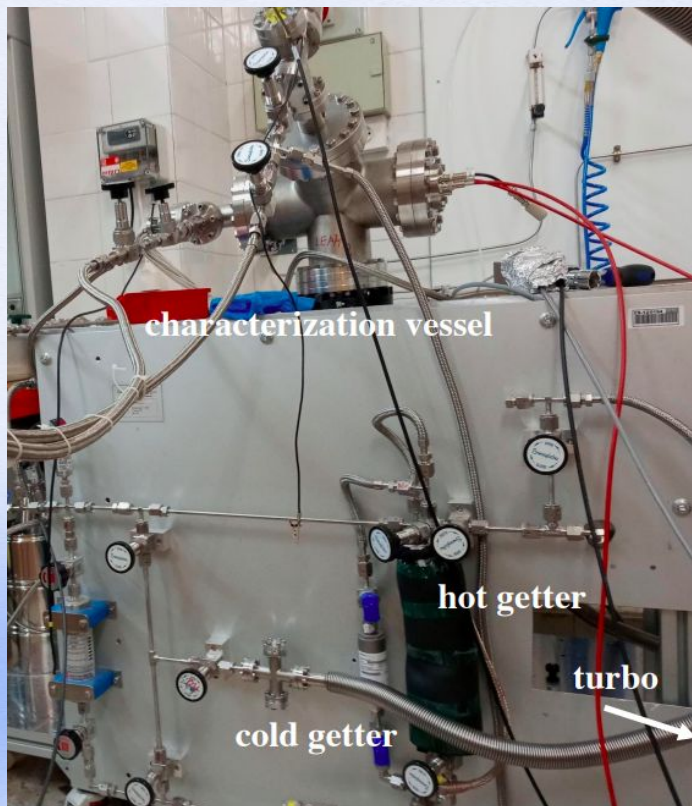
Experimental Campaign

A batch of structures with different configurations was produced and shipped to **IGFAE**, Spain where it was tested during summer.

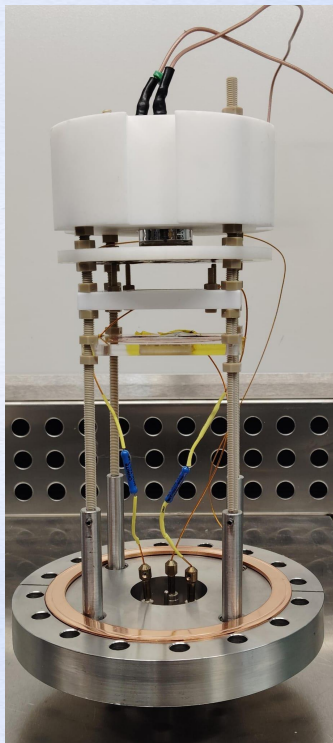
Structure	Size (cm ²)	Hole diameter (mm)	Pitch (mm)
A	5x5	2	4
B	5x5	3	5
C	7x7	2	4

- First step, characterization of these structures before cryogenic tests.

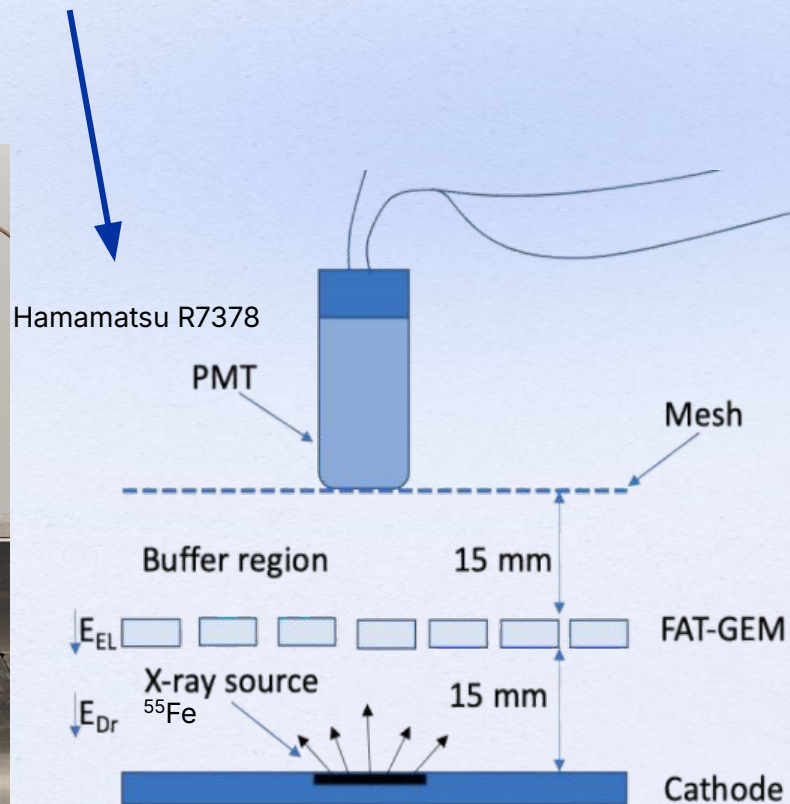
Setup



@IGFAE, Spain

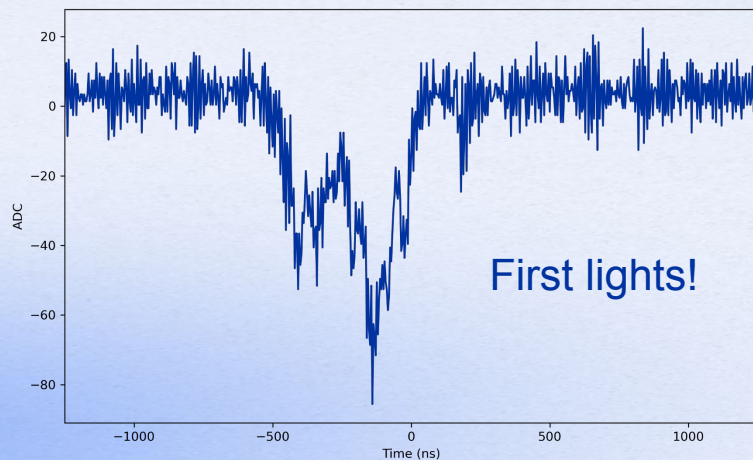


BLIND TO AR LIGHT

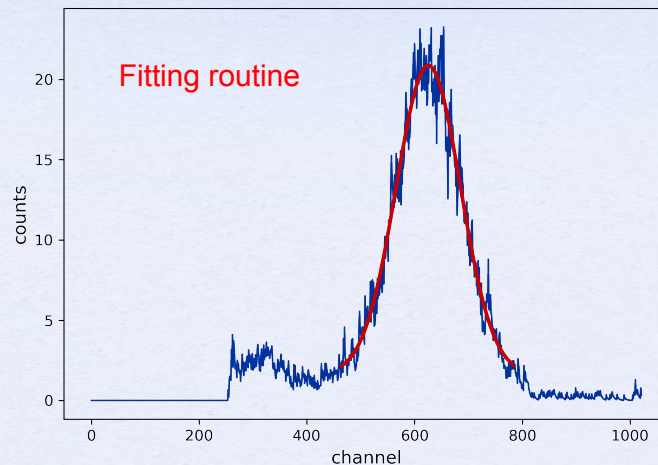


Results

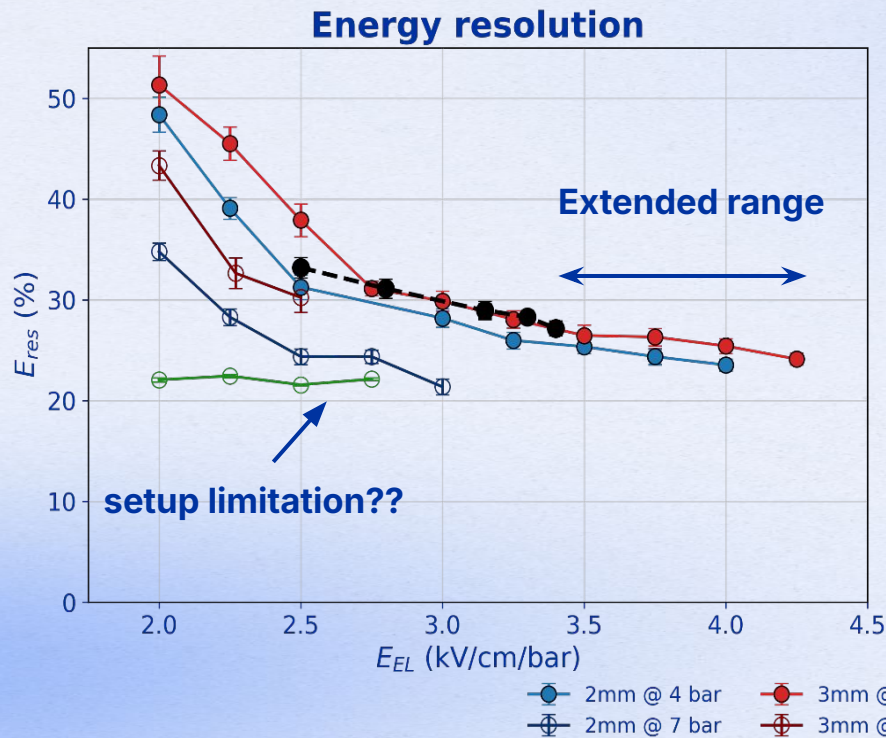
- **Ar at 4 bar and 293 K → equivalent density to cryogenic operation (1 bar, 87.5 K)**
 - Initial commissioning was done in Ar/Xe (99/1) at 4 bar.
 - Cold getter used to purify Ar



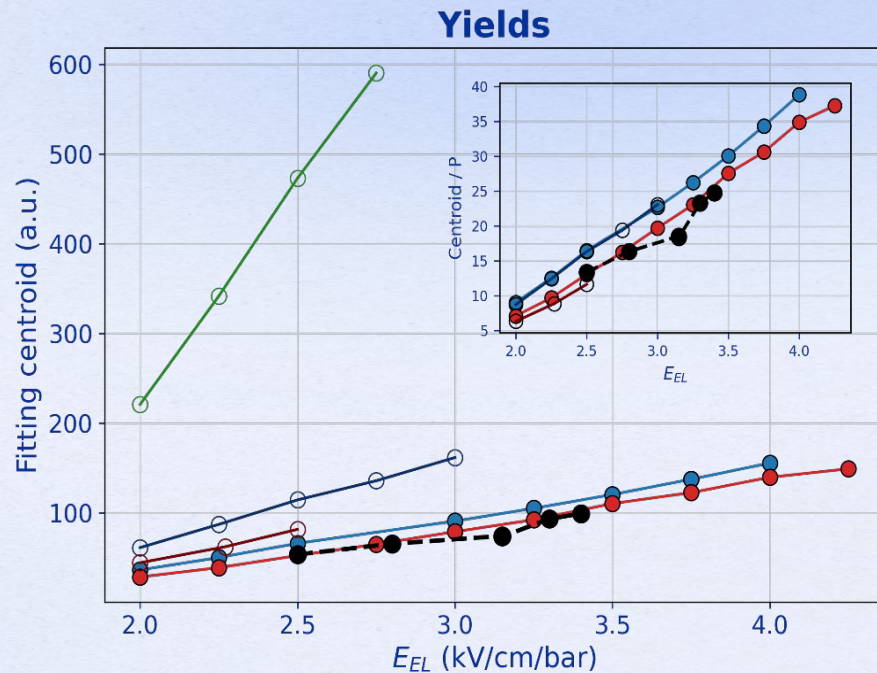
Pre-amplifier
+
Amplifier
+
MCA



Results



A

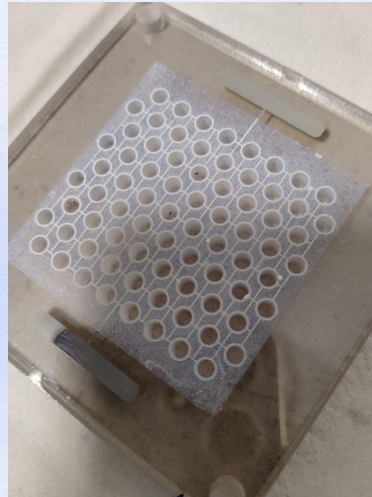
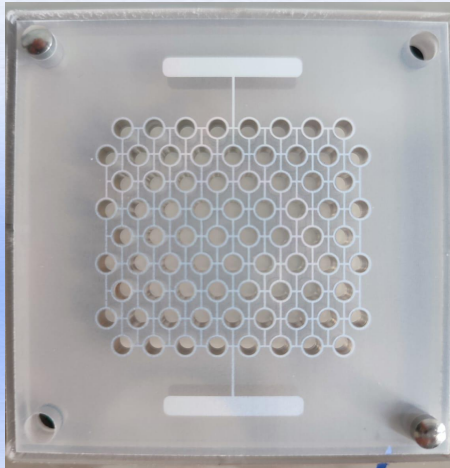


B

Ongoing Work

Batch of structures produced at CERN Workshop are being tested right now at IGFAE

- **Semi-transparent electrode** allowing for S1 detection
- First tests with 5.5 MeV alpha source
- **Smooth operation**, no strong indication of charging-up from TPB at the FAT-GEM cathode



S1 !!



Ongoing Work

- Batch of structures produced at CERN Workshop are being tested right now at IGFAE
 - **Semi-transparent electrode** allowing for S1 detection
- New batch of structures produced at AstroCeNT to be tested in Warsaw in **cryogenic conditions** as a first approach to dual-phase applications.
- **Simulations:**
 - Optimize optical response (WLSE and light collection)
 - Understand effects of hole size variations and shapes in detector response.

ArGset @CEZAMAT



Conclusions

- A revision of the fabrication process of FAT GEMs was undertaken at AstroCeNT facilities:
 - ITO adhesive film replaced by magnetron sputtered ITO (improved transparency from 80% to 90%).
 - Replacing ESR adhesive film for evaporated Aluminum (eliminates charging up keeping similar reflectivity).
 - Replacing CNC for laser drilling.
- FAT GEM performance improves over previous structures with room for improvement (optimization of TPB evaporation - WLS eff 40-50% from simulation).
- A second production batch at CERN made with a semitransparent cathode.



DRD1
Gaseous Detector Technologies



Thank you!

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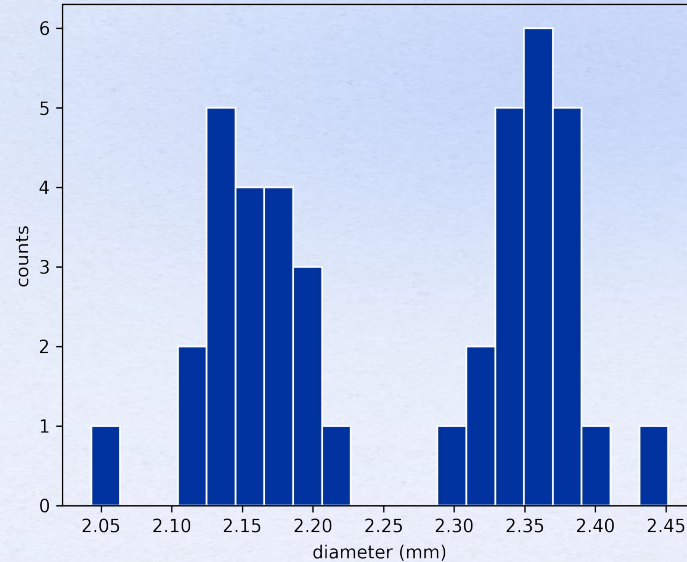
Laser drilling



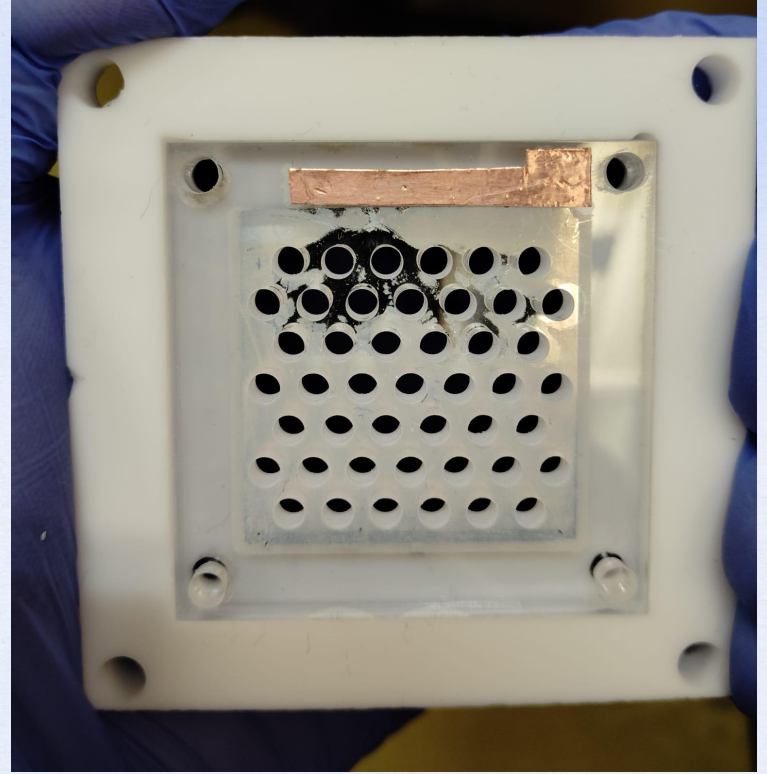
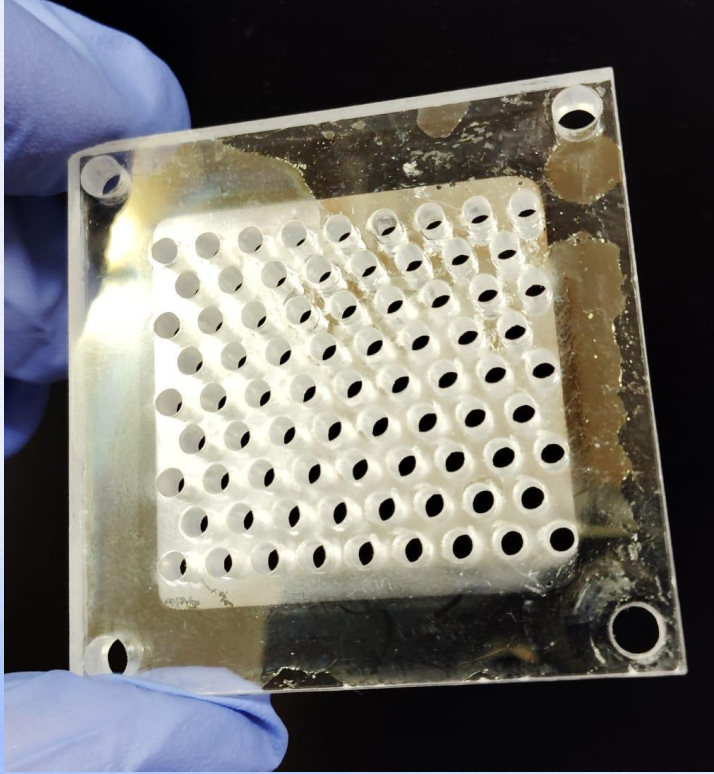
Main **advantages:**

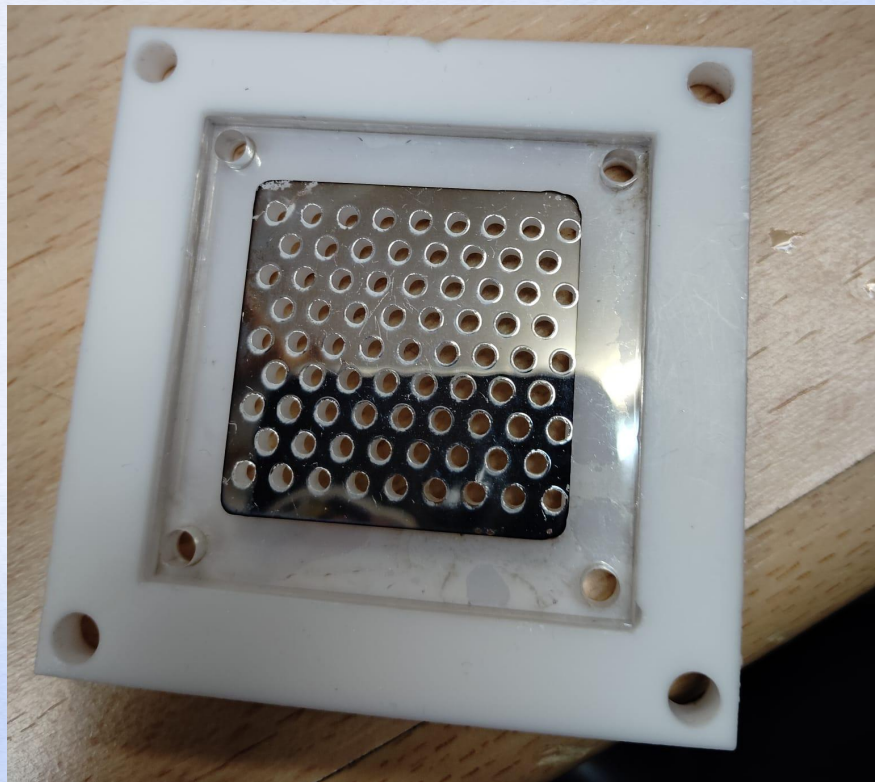
- Fully autonomous production
- Easy and fast production
- Conical holes (?)

Hole size characterization



- **Side down:** 2.157 ± 0.034 (mm)
- **Side up:** 2.358 ± 0.026 (mm)





Yield deterioration

